

Preliminary



May 2001  
Revised May 2001

# FSTU16211

## 24-Bit Bus Switch with –2V Undershoot Protection (Preliminary)

### General Description

The Fairchild Switch FSTU16211 provides 24-bits of high-speed CMOS TTL-compatible bus switching. The low On Resistance of the switch allows inputs to be connected to outputs without adding propagation delay or generating additional ground bounce noise.

The device is organized as a 12-bit or 24-bit bus switch. When  $\overline{OE}_1$  is LOW, the switch is ON and Port 1A is connected to Port 1B. When  $\overline{OE}_2$  is LOW, Port 2A is connected to Port 2B. The A and B Ports are protected against undershoot to support an extended range to 2.0V below ground. Fairchild's integrated Undershoot Hardened Circuit (UHC™) senses undershoot at the I/O and responds by preventing voltage differentials from developing and turning the switch on.

### Features

- Undershoot hardened to –2V (A and B Ports)
- Slower output enable times to prevent signal disruption
- 4Ω switch connection between two ports
- Minimal propagation delay through the switch
- Low  $I_{CC}$
- Zero bounce in flow-through mode
- Control inputs compatible with TTL level
- See Applications Note AN-5008 for details

### Ordering Code:

Order Number	Package Number	Package Description
FSTU16211MTD	MTD56	56-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide

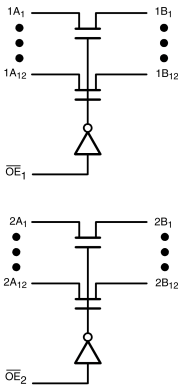
Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

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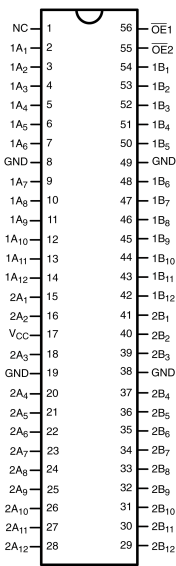
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Logic Diagram



Connection Diagram



Truth Table

Inputs		Inputs/Outputs	
$\overline{OE}_1$	$\overline{OE}_2$	1A, 1B	2A, 2B
L	L	1A = 1B	2A = 2B
L	H	1A = 1B	Z
H	L	Z	2A = 2B
H	H	Z	Z

Pin Descriptions

Pin Name	Description
$\overline{OE}_1, \overline{OE}_2$	Bus Switch Enables
1A, 2A	Bus A
1B, 2B	Bus B

**Absolute Maximum Ratings**(Note 1)

Supply Voltage ( $V_{CC}$ )	-0.5V to +7.0V
DC Switch Voltage ( $V_S$ ) (Note 2)	-0.5V to +7.0V
DC Input Control	
Pin Voltage ( $V_{IN}$ ) (Note 3)	-0.5V to +7.0V
DC Input Diode Current ( $I_{IK}$ ) $V_{IN} < 0V$	-50 mA
DC Output Current ( $I_{OUT}$ )	128 mA
DC $V_{CC}$ /GND Current ( $I_{CC}/I_{GND}$ )	+/- 100 mA
Storage Temperature Range ( $T_{STG}$ )	-65°C to +150 °C

**Recommended Operating Conditions** (Note 4)

Power Supply Operating ( $V_{CC}$ )	4.0V to 5.5V
Input Voltage ( $V_{IN}$ )	0V to 5.5V
Output Voltage ( $V_{OUT}$ )	0V to 5.5V
Input Rise and Fall Time ( $t_r, t_f$ )	
Switch Control Input	0 ns/V to 5 ns/V
Switch I/O	0 ns/V to DC
Free Air Operating Temperature ( $T_A$ )	-40 °C to +85 °C

**Note 1:** The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum rating. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

**Note 2:**  $V_S$  is the voltage observed/applied at either the A or B Ports across the switch.

**Note 3:** The input and output negative voltage ratings may be exceeded if the input and output diode current ratings are observed.

**Note 4:** Unused control inputs must be held HIGH or LOW. They may not float.

**DC Electrical Characteristics**

Symbol	Parameter	$V_{CC}$ (V)	$T_A = -40\text{ °C to }+85\text{ °C}$			Units	Conditions
			Min	Typ (Note 5)	Max		
$V_{IK}$	Clamp Diode Voltage	4.5			-1.2	V	$I_{IN} = -18\text{ mA}$
$V_{IH}$	HIGH Level Input Voltage	4.0-5.5	2.0			V	
$V_{IL}$	LOW Level Input Voltage	4.0-5.5			0.8	V	
$I_I$	Input Leakage Current	5.5			±1.0	µA	$0 \leq V_{IN} \leq 5.5V$
		0			10	µA	$V_{IN} = 5.5V$
$I_{OZ}$	OFF-STATE Leakage Current	5.5			±1.0	µA	$0 \leq A, B \leq V_{CC}$
$R_{ON}$	Switch On Resistance (Note 6)	4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 64\text{ mA}$
		4.5		4	7	Ω	$V_{IN} = 0V, I_{IN} = 30\text{ mA}$
		4.5		8	12	Ω	$V_{IN} = 2.4V, I_{IN} = 15\text{ mA}$
		4.0		11	20	Ω	$V_{IN} = 2.4V, I_{IN} = 15\text{ mA}$
$I_{CC}$	Quiescent Supply Current	5.5			3	µA	$V_{IN} = V_{CC}$ or GND, $I_{OUT} = 0$
$\Delta I_{CC}$	Increase in $I_{CC}$ per Input	5.5			2.5	mA	One Input at 3.4V Other Inputs at $V_{CC}$ or GND
$V_{IKU}$	Voltage Undershoot	5.5			-2.0	V	$0.0\text{ mA} \geq I_{IN} \geq -50\text{ mA}$ $\overline{OE}_{1,2} = 5.5v$

**Note 5:** Typical values are at  $V_{CC} = 5.0V$  and  $T_A = +25^\circ C$

**Note 6:** Measured by the voltage drop between A and B pins at the indicated current through the switch. On Resistance is determined by the lower of the voltages on the two (A or B) pins.

## AC Electrical Characteristics

Symbol	Parameter	T <sub>A</sub> = -40 °C to +85 °C, C <sub>L</sub> = 50pF, R <sub>U</sub> = R <sub>D</sub> = 500Ω				Units	Conditions	Figure Number
		V <sub>CC</sub> = 4.5 – 5.5V		V <sub>CC</sub> = 4.0V				
		Min	Max	Min	Max			
t <sub>PHL</sub> , t <sub>PLH</sub>	Propagation Delay Bus to Bus (Note 7)		0.25		0.25	ns	V <sub>I</sub> = OPEN	Figures 2, 3
t <sub>PZH</sub> , t <sub>PZL</sub>	Output Enable Time	7.0	30.0		35.0	ns	V <sub>I</sub> = 7V for t <sub>PZL</sub> V <sub>I</sub> = OPEN for t <sub>PZH</sub>	Figures 2, 3
t <sub>PHZ</sub> , t <sub>PLZ</sub>	Output Disable Time	1.5	7.0		7.2	ns	V <sub>I</sub> = 7V for t <sub>PLZ</sub> V <sub>I</sub> = OPEN for t <sub>PHZ</sub>	Figures 2, 3

**Note 7:** This parameter is guaranteed by design but is not tested. The bus switch contributes no propagation delay other than the RC delay of the typical On Resistance of the switch and the 50pF load capacitance, when driven by an ideal voltage source (zero output impedance).

## Capacitance (Note 8)

Symbol	Parameter	Typ	Max	Units	Conditions
$C_{IN}$	Control Pin Input Capacitance	3		pF	$V_{CC} = 5.0\text{V}$
$C_{IO}$	Input/Output Capacitance	6		pF	$V_{CC}$ , $\overline{OE} = 5.0\text{V}$

**Note 8:**  $T_A = +25^\circ\text{C}$ ,  $f = 1\text{ MHz}$ , Capacitance is characterized but not tested.

## Undershoot Characteristic

Symbol	Parameter	Min	Typ	Max	Units	Conditions
$V_{OUTU}$	Output Voltage During Undershoot	2.5	$V_{OH} - 0.3$		V	

**Note 9:** This test is intended to characterize the device's protective capabilities by maintaining output signal integrity during an input transient voltage undershoot event.

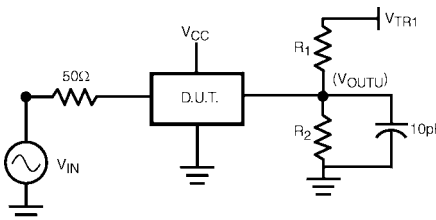
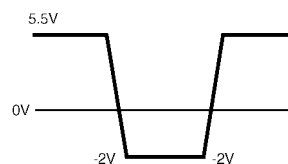


FIGURE 1.

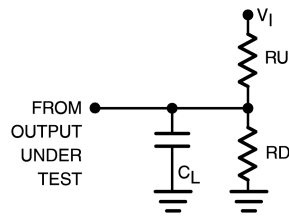
## Device Test Conditions

Parameter	Value	Units
$V_{IN}$	see Waveform	V
$R_1 = R_2$	100K	$\Omega$
$V_{TRI}$	11.0	V
$V_{CC}$	5.5	V

## Transient Input Voltage ( $V_{IN}$ ) Waveform



## AC Loading and Waveforms



**Note:** Input driven by 50  $\Omega$  source terminated in 50  $\Omega$

**Note:**  $C_L$  includes load and stray capacitance

**Note:** Input PRR = 1.0 MHz,  $t_W = 500$  ns

FIGURE 2. AC Test Circuit

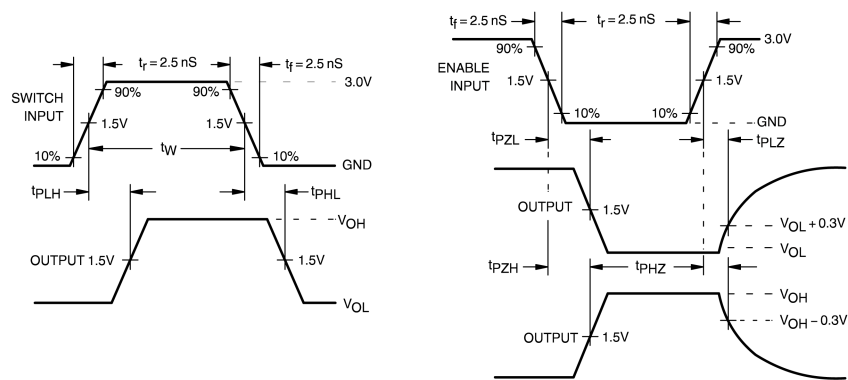
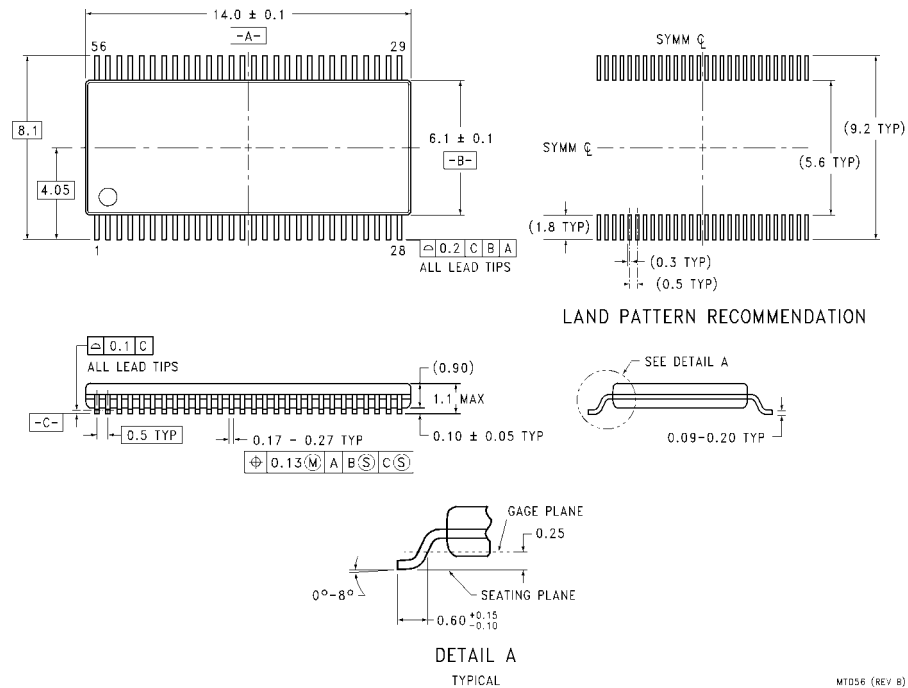


FIGURE 3. AC Waveforms

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## Physical Dimensions inches (millimeters) unless otherwise noted



56-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 6.1mm Wide  
Package Number MTD56

## Technology Description

The Fairchild Switch family derives from and embodies Fairchild's proven switch technology used for several years in its 74LVX3L384 (FST3384) bus switch product.

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